

Low-Cost 3.3 V Zero Delay Buffer

The MPC962309 is a zero delay buffer designed to distribute high-speed clocks. Available in a 16-pin SOIC or TSSOP package, the device accepts one reference input and drives nine low-skew clocks. The MPC962305 is the 8-pin version of the MPC962309 which drives five outputs with one reference input. The -1H versions of these devices have higher drive than the -1 devices and can operate up to 100/-133 MHz frequencies. These parts have on-chip PLLs which lock to an input clock presented on the REF pin. The PLL feedback is on-chip and is obtained from the CLOCKOUT pad.

Features

- 1:5 LVCMOS zero-delay buffer (MPC962305)
- 1:9 LVCMOS zero-delay buffer (MPC962309)
- Zero input-output propagation delay
- Multiple low-skew outputs
- 250 ps max output-output skew
- 700 ps max device-device skew
- Supports a clock I/O frequency range of 10 MHz to 133 MHz, compatible with CPU and PCI bus frequencies
- Low jitter, 200 ps max cycle-cycle, and compatible with Pentium® based systems
- Test Mode to bypass PLL (MPC962309 only. See "Select Input Decoding")
- 8-pin SOIC or 8-pin TSSOP package (MPC962305); 16-pin SOIC or 16-pin TSSOP package (MPC962309)
- Single 3.3 V supply
- Ambient temperature range: -40°C to +85°C
- Compatible with the CY2305, CY23S05, CY2309, CY23S09
- Spread spectrum compatible

Functional Description

The MPC962309 has two banks of four outputs each, which can be controlled by the Select Inputs as shown in [Table 3. Select Input Decoding for MPC962309](#). Bank B can be tri-stated if all of the outputs are not required. Select inputs also allow the input clock to be directly applied to the outputs for chip and system testing purposes.

The MPC962305 and MPC962309 PLLs enter a power down state when there are no rising edges on the REF input. During this state, all of the outputs are in tristate, the PLL is turned off, and there is less than 25.0 μ A of current draw for the device. The PLL shuts down in one additional case as shown in [Table 3. Select Input Decoding for MPC962309](#).

Multiple MPC962305 and MPC962309 devices can accept the same input clock and distribute it throughout the system. In this situation, the difference between the output skews of two devices will be less than 700 ps.

All outputs have less than 200 ps of cycle-cycle jitter. The input-to-output propagation delay on both devices is guaranteed to be less than 350 ps and the output-to-output skew is guaranteed to be less than 250 ps.

The MPC962305 and MPC962309 are available in two/three different configurations, as shown on the ordering information page. The MPC962305-1/MPC962309-1 are the base parts. High drive versions of those devices, MPC962305-1H and MPC962309-1H, are available to provide faster rise and fall times of the base device.

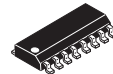
MPC962305 MPC962309



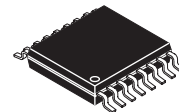
D SUFFIX
8-LEAD SOIC PACKAGE
CASE 751-06



DT SUFFIX
8-LEAD TSSOP PACKAGE
CASE 948J-01

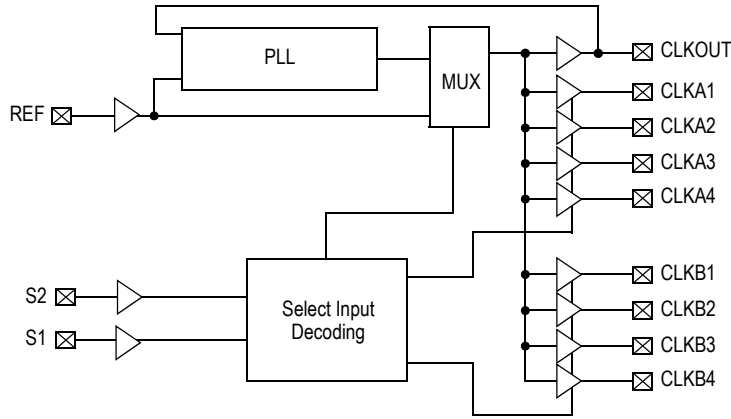


D SUFFIX
16-LEAD SOIC PACKAGE
CASE 751B-05



DT SUFFIX
16-LEAD TSSOP PACKAGE
CASE 948F-01

Block Diagram



Pin Configuration

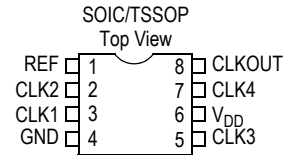
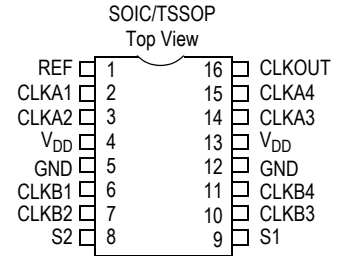


Table 1. Pin Description for MPC962309

| Pin | Signal | Description |
|-----|---------------------|--|
| 1 | REF ¹ | Input reference frequency, 5 V-tolerant input |
| 2 | CLKA1 ² | Buffered clock output, Bank A |
| 3 | CLKA2 ² | Buffered clock output, Bank A |
| 4 | V _{DD} | 3.3 V supply |
| 5 | GND | Ground |
| 6 | CLKB1 ² | Buffered clock output, Bank B |
| 7 | CLKB2 ² | Buffered clock output, Bank B |
| 8 | S2 ³ | Select input, bit 2 |
| 9 | S1 ³ | Select input, bit 1 |
| 10 | CLKB3 ² | Buffered clock output, Bank B |
| 11 | CLKB4 ² | Buffered clock output, Bank B |
| 12 | GND | Ground |
| 13 | V _{DD} | 3.3 V supply |
| 14 | CLKA3 ² | Buffered clock output, Bank A |
| 15 | CLKA4 ² | Buffered clock output, Bank A |
| 16 | CLKOUT ² | Buffered output, internal feedback on this pin |

Table 2. Pin Description for MPC962305

| Pin | Signal | Description |
|-----|---------------------|---|
| 1 | REF ¹ | Input reference frequency, 5 V-tolerant input |
| 2 | CLK2 ² | Buffered clock output |
| 3 | CLK1 ² | Buffered clock output |
| 4 | GND | Ground |
| 5 | CLK3 ² | Buffered clock output |
| 6 | V _{DD} | 3.3 V supply |
| 7 | CLK4 ² | Buffered clock output |
| 8 | CLKOUT ² | Buffered clock output internal feedback on this pin |

1. Weak pull-down.
2. Weak pull-down on all outputs.
3. Weak pull-ups on these inputs.

Table 3. Select Input Decoding for MPC962309

| S2 | S1 | CLOCK A1–A4 | CLOCK B1–B4 | CLKOUT ¹ | Output Source | PLL Shutdown |
|----|----|-------------|-------------|---------------------|---------------|--------------|
| 0 | 0 | Three-State | Three-State | Driven | PLL | N |
| 0 | 1 | Driven | Three-State | Driven | PLL | N |
| 1 | 0 | Driven | Driven | Driven | Reference | Y |
| 1 | 1 | Driven | Driven | Driven | PLL | N |

1. This output is driven and has an internal feedback for the PLL. The load on this output can be adjusted to change the skew between the reference and output.

Table 4. Maximum Ratings

| Characteristics | Value | Unit |
|---|----------------------|------|
| Supply Voltage to Ground Potential | -0.5 to +3.9 | V |
| DC Input Voltage (Except Ref) | -0.5 to $V_{DD}+0.5$ | V |
| DC Input Voltage REF | -0.5 to 5.5 | V |
| Storage Temperature | -65 to +150 | °C |
| Junction Temperature | 150 | °C |
| Static Discharge Voltage (per MIL-STD-883, Method 3015) | >2000 | V |

Table 5. Operating Conditions for MPC962305-X and MPC962309-X Industrial Temperature Devices

| Parameter | Description | Min | Max | Unit |
|-----------|---|-----|-----|------|
| V_{DD} | Supply Voltage | 3.0 | 3.6 | V |
| T_A | Operating Temperature (Ambient Temperature) | -40 | 85 | °C |
| C_L | Load Capacitance, below 100 MHz | | 30 | pF |
| C_L | Load Capacitance, from 100 MHz to 133 MHz | | 10 | pF |
| C_{IN} | Input Capacitance | | 7 | pF |

Table 6. Electrical Characteristics for MPC962305-X and MPC962309-X Industrial Temperature Devices¹

| Parameter | Description | Test Conditions | Min | Max | Unit |
|--------------------|----------------------------------|--|-----|-------|------|
| V_{IL} | Input LOW Voltage ² | | | 0.8 | V |
| V_{IH} | Input HIGH Voltage ² | | 2.0 | | V |
| I_{IL} | Input LOW Current | $V_{IN} = 0\text{ V}$ | | 50.0 | μA |
| I_{IH} | Input HIGH Current | $V_{IN} = V_{DD}$ | | 100.0 | μA |
| V_{OL} | Output LOW Voltage ³ | $I_{OL} = 8\text{ mA} (-1)$ $I_{OH} = 12\text{ mA} (-1H)$ | | 0.4 | V |
| V_{OH} | Output HIGH Voltage ³ | $I_{OH} = -8\text{ mA} (-1)$ $I_{OL} = -12\text{ mA} (-1H)$ | 2.4 | | V |
| I_{DD} (PD mode) | Power Down Supply Current | REF = 0 MHz | | 25.0 | μA |
| I_{DD} | Supply Current | Unloaded outputs at 66.67 MHz, SEL inputs at V_{DD} | | 35.0 | mA |

- All parameters are specified with loaded outputs.
- REF input has a threshold voltage of $V_{PP}/2$.
- Parameter is guaranteed by design and characterization. Not 100% tested in production.

Table 7. Switching Characteristics for MPC962305-1 and MPC962309-1 Industrial Temperature Devices¹

| Parameter | Name | Test Conditions | Min | Typ | Max | Unit |
|-------------------|---|--|------|------|--------|------|
| t ₁ | Output Frequency | 30-pF load | 10 | | 100 | MHz |
| | | 10-pF load | 10 | | 133.33 | MHz |
| | Duty Cycle ² = t ₂ ÷ t ₁ | Measured at 1.4 V, F _{OUT} = 66.67 MHz | 40.0 | 50.0 | 60.0 | % |
| t ₃ | Rise Time ² | Measured between 0.8 V and 2.0 V | | | 2.50 | ns |
| t ₄ | Fall Time ² | Measured between 0.8 V and 2.0 V | | | 2.50 | ns |
| t ₅ | Output to Output Skew ² | All outputs equally loaded | | | 250 | ps |
| t _{6A} | Delay, REF Rising Edge to CLKOUT Rising Edge ² | Measured at V _{DD} /2 | | 0 | ±350 | ps |
| t _{6B} | Delay, REF Rising Edge to CLKOUT Rising Edge ² | Measured at V _{DD} /2. Measured in PLL Bypass Mode, MPC962309 device only | 1 | 5 | 8.7 | ns |
| t ₇ | Device to Device Skew ² | Measured at V _{DD} /2 on the CLKOUT pins of devices | | 0 | 700 | ps |
| t _J | Cycle to Cycle Jitter ² | Measured at 66.67 MHz, loaded outputs | | | 200 | ps |
| t _{LOCK} | PLL Lock Time ² | Stable power supply, valid clock presented on REF pin | | | 1.0 | ms |

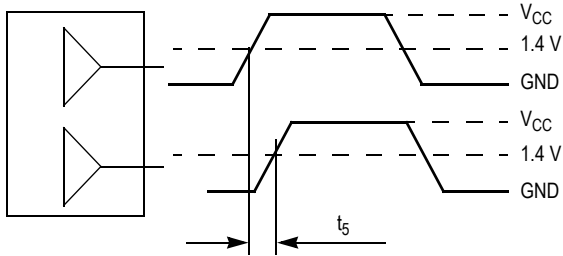
1. All parameters are specified with loaded outputs.
2. Parameter is guaranteed by design and characterization. Not 100% tested in production.

Table 8. Switching Characteristics for MPC962305-1H and MPC962309-1H Industrial Temperature Devices¹

| Parameter | Name | Test Conditions | Min | Typ | Max | Unit |
|-------------------|---|--|------|------|--------|------|
| t ₁ | Output Frequency | 30-pF load | 10 | | 100 | MHz |
| | | 10-pF load | 10 | | 133.33 | MHz |
| | Duty Cycle ² = t ₂ ÷ t ₁ | Measured at 1.4 V, F _{OUT} = 66.67 MHz | 40.0 | 50.0 | 60.0 | % |
| | Duty Cycle ² = t ₂ ÷ t ₁ | Measured at 1.4 V, F _{OUT} < 50 MHz | 45.0 | 55.0 | 55.0 | % |
| t ₃ | Rise Time ² | Measured between 0.8 V and 2.0 V | | | 1.50 | ns |
| t ₄ | Fall Time ² | Measured between 0.8 V and 2.0 V | | | 1.50 | ns |
| t ₅ | Output to Output Skew ² | All outputs equally loaded | | | 250 | ps |
| t _{6A} | Delay, REF Rising Edge to CLKOUT Rising Edge ² | Measured at V _{DD} /2 | | 0 | ±350 | ps |
| t _{6B} | Delay, REF Rising Edge to CLKOUT Rising Edge ² | Measured at V _{DD} /2. Measured in PLL Bypass Mode, MPC962309 device only | 1 | 5 | 8.7 | ns |
| t ₇ | Device to Device Skew ² | Measured at V _{DD} /2 on the CLKOUT pins of devices | | 0 | 700 | ps |
| t ₈ | Output Slew Rate ² | Measured between 0.8 V and 2.0 V using Test Circuit #2 | 1 | | | V/ns |
| t _J | Cycle to Cycle Jitter ² | Measured at 66.67 MHz, loaded outputs | | | 200 | ps |
| t _{LOCK} | PLL Lock Time ² | Stable power supply, valid clock presented on REF pin | | | 1.0 | ms |

1. All parameters are specified with loaded outputs.
2. Parameter is guaranteed by design and characterization. Not 100% tested in production.

APPLICATIONS INFORMATION



The pin-to-pin skew is defined as the worst case difference in propagation delay between any similar delay path within a single device

Figure 1. Output-to-Output Skew $t_{SK(O)}$

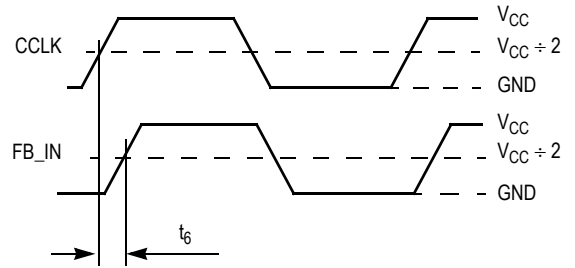
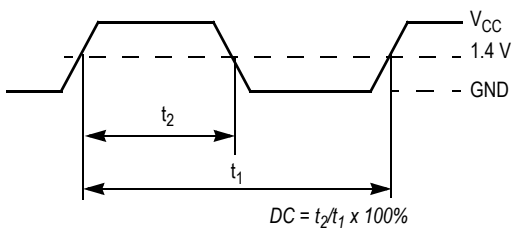


Figure 2. Static Phase Offset Test Reference



The time from the PLL controlled edge to the non-controlled edge, divided by the time between PLL controlled edges, expressed as a percentage

Figure 3. Output Duty Cycle (DC)

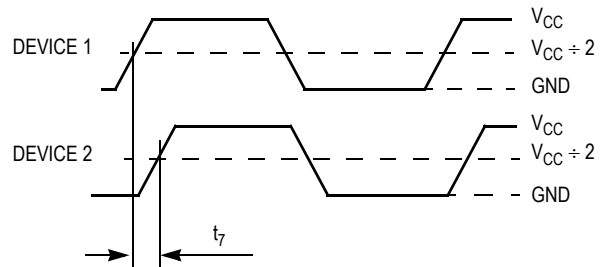
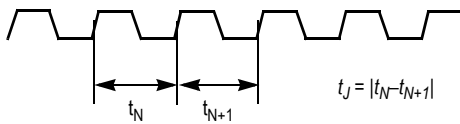


Figure 4. Device-to-Device Skew



The variation in cycle time of a signal between adjacent cycles, over a random sample of adjacent cycle pairs

Figure 5. Cycle-to-Cycle Jitter

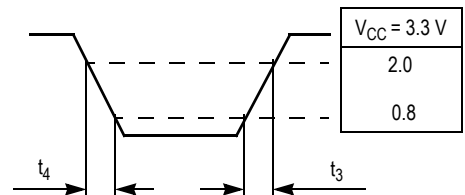
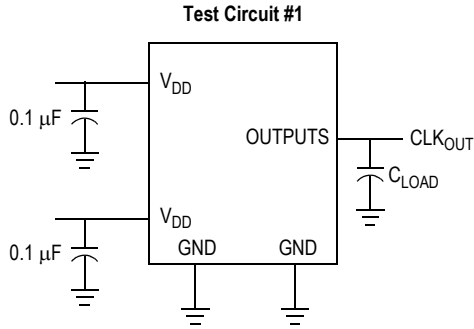
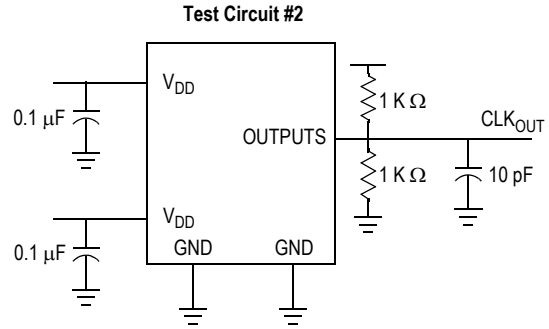


Figure 6. Output Transition Time Test Reference



Test Circuit for all parameters except t_b



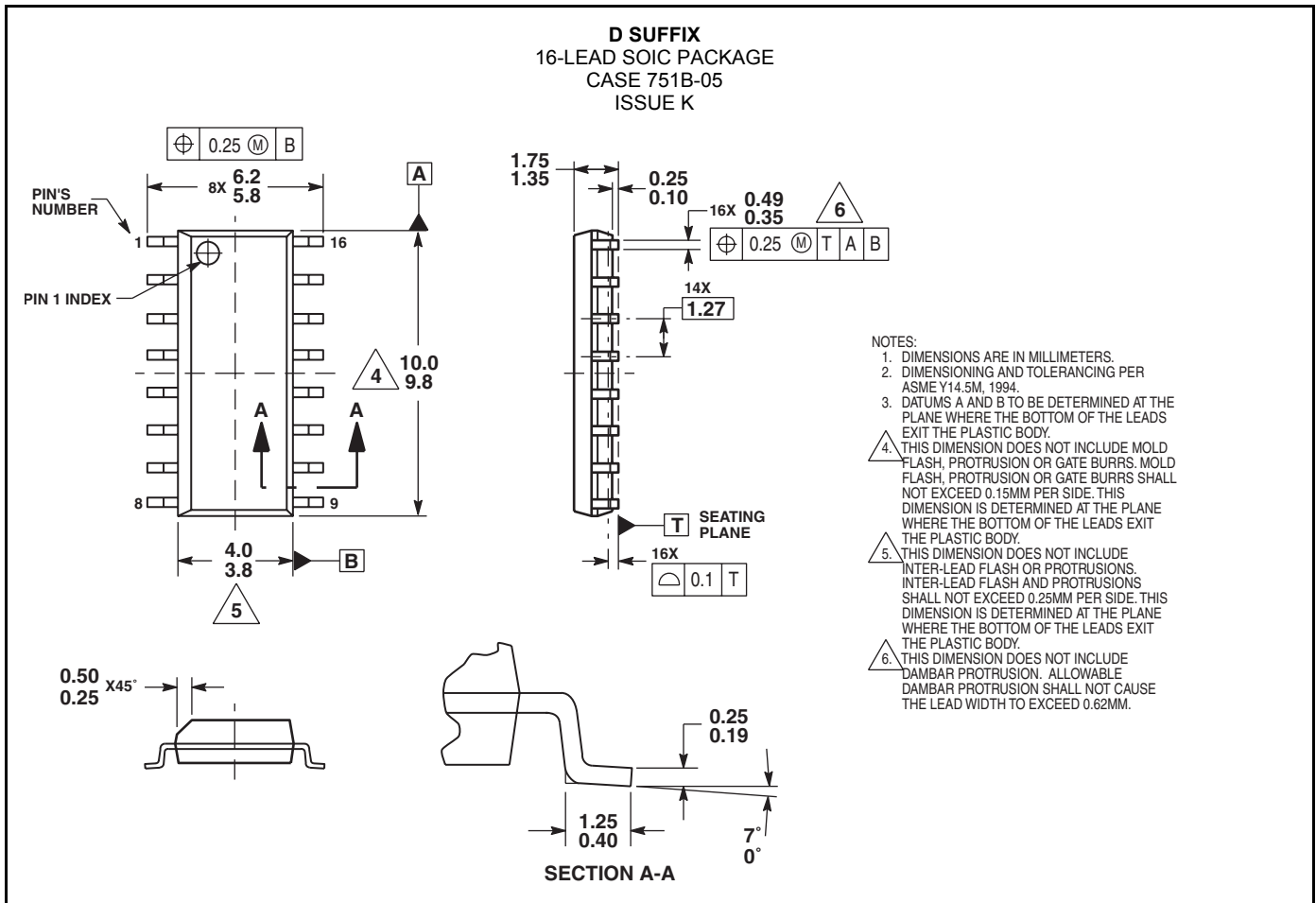
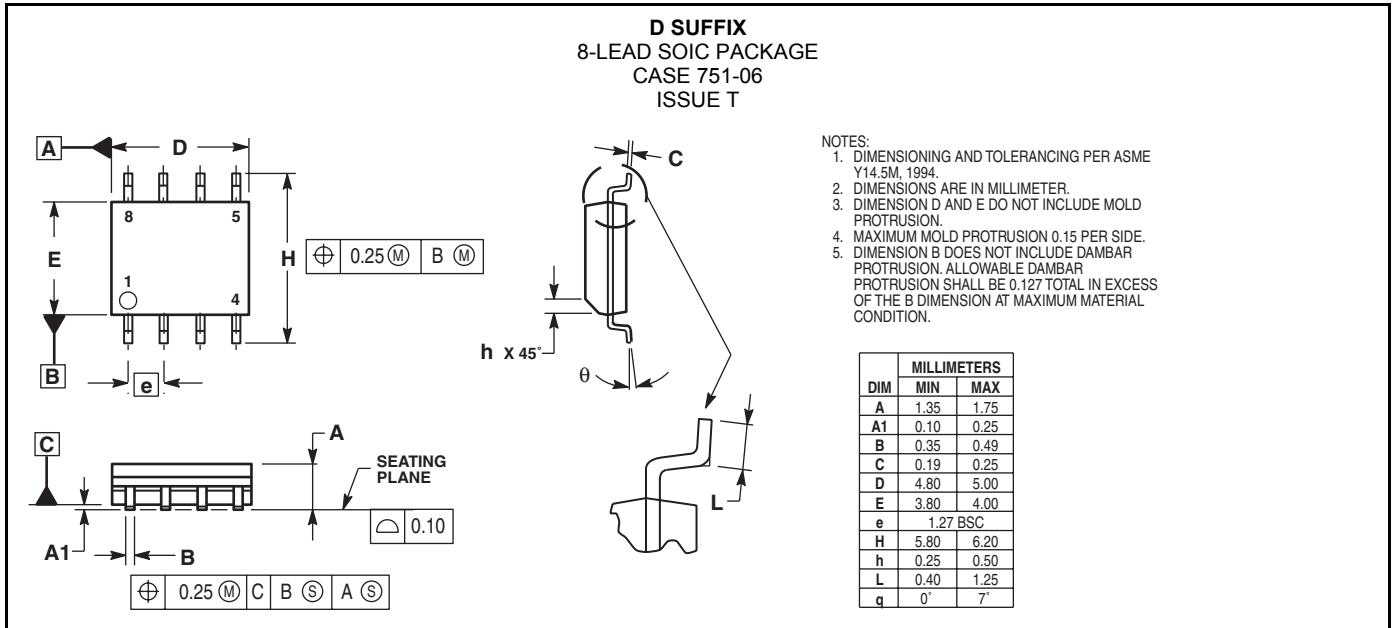
Test Circuit for t_b , Output slew rate on -1H, -5 device

Table 9. Ordering Information

| Ordering Code | Package Type |
|------------------|-----------------------------------|
| MPC962305D-1 | 8-pin 150-mil SOIC |
| MPC962305D-1R2 | 8-pin 150-mil SOIC-Tape and Reel |
| MPC962305D-1H | 8-pin 150-mil SOIC |
| MPC962305D-1HR2 | 8-pin 150-mil SOIC-Tape and Reel |
| MPC962305DT-1H | 8-pin 150-mil TSSOP |
| MPC962305DT-1HR2 | 8-pin 150-mil TSSOP-Tape and Reel |
| MPC962309D-1 | 16-pin 150-mil SOIC |
| MPC962309D-1R2 | 16-pin 150-mil SOIC-Tape and Reel |
| MPC962309D-1H | 16-pin 150-mil SOIC |
| MPC962309D-1HR2 | 16-pin 150-mil SOIC-Tape and Reel |
| MPC962309DT-1H | 16-pin 4.4-mm TSSOP |
| MPC962309DT-1HR2 | 16-pin 4.4-mm TSSOP-Tape and Reel |

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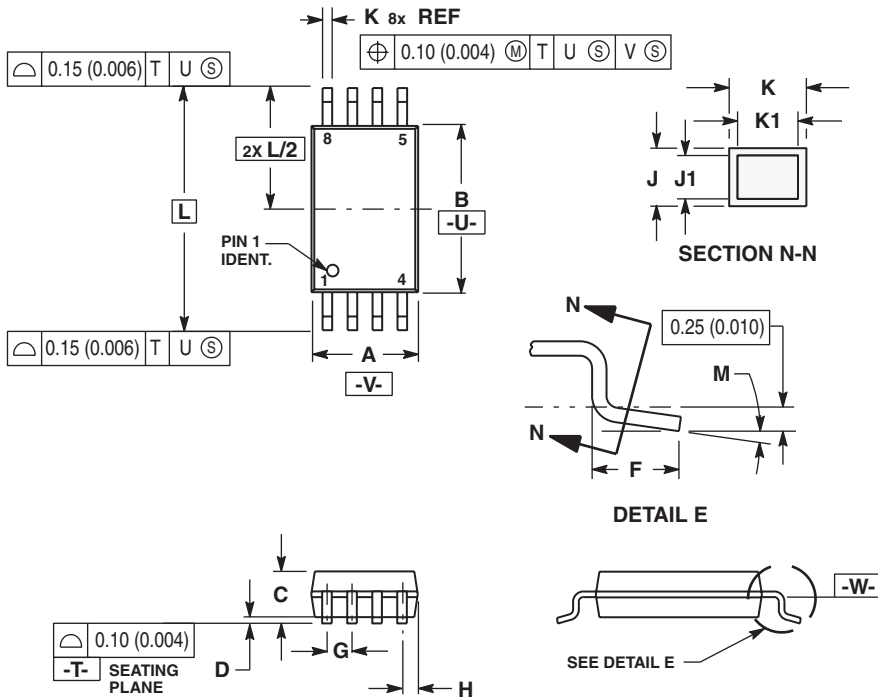
PACKAGE DIMENSIONS



Freescale Semiconductor, Inc.

PACKAGE DIMENSIONS

DT SUFFIX
8-LEAD TSSOP PACKAGE
CASE 948J-01
ISSUE O

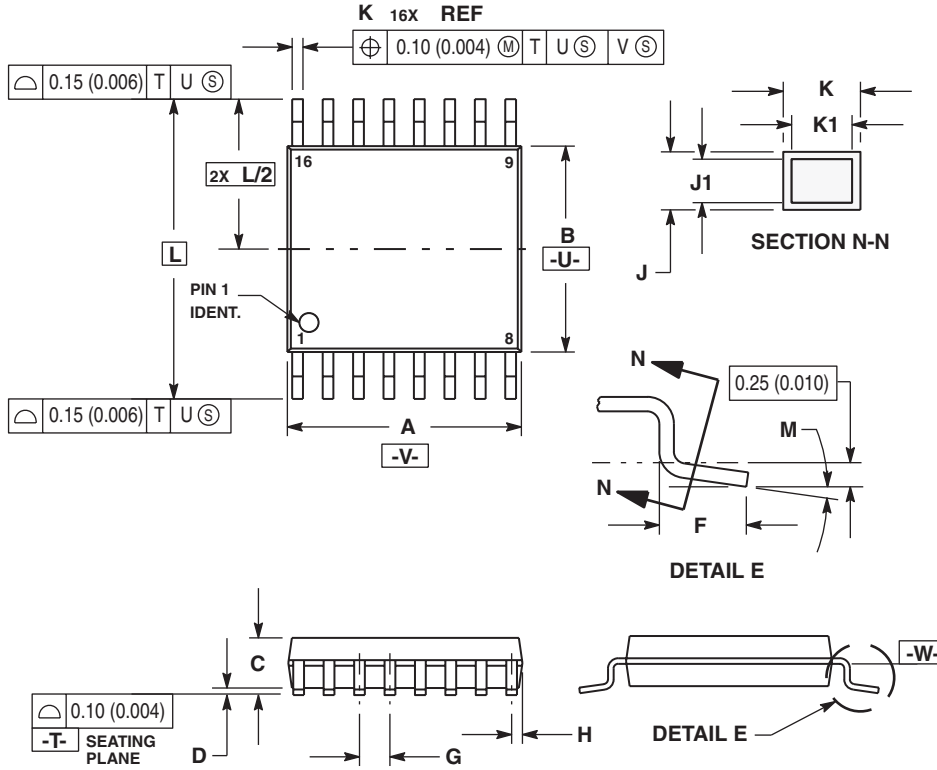


- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
 4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
 5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
 6. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
 7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 2.90 | 3.10 | 0.114 | 0.122 |
| B | 4.30 | 4.50 | 0.169 | 0.177 |
| C | --- | 1.20 | --- | 0.047 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.50 | 0.75 | 0.020 | 0.030 |
| G | 0.65 BSC | | 0.026 BSC | |
| H | 0.50 | 0.60 | 0.020 | 0.024 |
| J | 0.09 | 0.20 | 0.004 | 0.008 |
| J1 | 0.09 | 0.16 | 0.004 | 0.006 |
| K | 0.19 | 0.30 | 0.007 | 0.012 |
| K1 | 0.19 | 0.25 | 0.007 | 0.010 |
| L | 6.40 BSC | | 0.252 BSC | |
| M | 0' | 8' | 0' | 8' |

PACKAGE DIMENSIONS

DT SUFFIX
16-LEAD TSSOP PACKAGE
CASE 948F-01
ISSUE O



NOTES:

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| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 4.90 | 5.10 | 0.193 | 0.200 |
| B | 4.30 | 4.50 | 0.169 | 0.177 |
| C | --- | 1.20 | --- | 0.047 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.50 | 0.75 | 0.020 | 0.030 |
| G | 0.65 BSC | | 0.026 BSC | |
| H | 0.18 | 0.28 | 0.007 | 0.011 |
| J | 0.09 | 0.20 | 0.004 | 0.008 |
| J1 | 0.09 | 0.16 | 0.004 | 0.006 |
| K | 0.19 | 0.30 | 0.007 | 0.012 |
| K1 | 0.19 | 0.25 | 0.007 | 0.010 |
| L | 6.40 BSC | | 0.252 BSC | |
| M | 0' | 8' | 0' | 8' |

NOTES

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